

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

219491US3

SERIAL NO.

10/073,910

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Yoshinobu TAKANO

FILING DATE

February 14, 2002

GROUP

2874

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>M</i>	AA	5,963,699	10/05/99	T. TANAKA, et al.			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
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	AL						
	AM						
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AO					
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

Hemang Singh

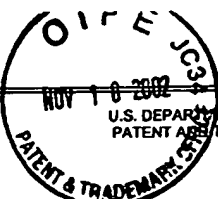
Date Considered

3/4/04

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Yoshinobu TANAKO			
				FILING DATE 02/14/02		GROUP 2874	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
M	AA	5,783,636	07/21/98	KOIKE, et al.			
M	AB	5,760,139	06/02/98	KOIKIE, et al.			
M	AC	6,271,312	08/08/01	KOIKE, et al.			
M	AD	5,916,971	05/29/99	KOIKE, et al.			
M	AE	6,071,441	06/06/00	KOGANEZAWA, et al.			
M	AF	6,074,511	06/13/00	TAKANO, et al.			
M	AG	6,225,382	05/01/01	MATSUKURA, et al.			
M	AH	6,166,125	12/27/00	SUGIYAMA, et al.			
M	AI	6,111,062	08/29/00	SHIROTA, et al.			
M	AJ	6,221,987	04/24/01	SUGIYAMA			
M	AK	6,448,452	09/10/02	KASHIWAGI, et al.			
	AL						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO						
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
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	AZ						
Examiner <i>Hemang Singhani</i>				Date Considered 3/04/04			

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
M	AA	4,629,284	12/16/86	F.-L. MALAVIEILLE			
M	AB	4,871,227	10/03/89	W. TILSE			
M	AC	5,195,153	03/16/93	L. FINZEL			
M	AD	4,779,954	10/25/88	Y. TATSUKAMI, et al.			
M	AE	5,692,089	11/25/97	G. J. SELLERS			
	AF						
	AG						
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	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
M	AO	0 065 096	11/24/82	EUROPE		
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

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	AX		
	AY		
	AZ		

☐ Additional References sheet(s) attached

Examiner

Hemant Sanghani

Date Considered

3/7/02

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